

FNK N-Channel Enhancement Mode Power MOSFET

Description

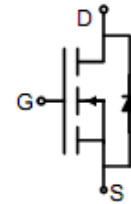
The FNK03N024A uses advanced trench technology and provide excellent $R_{DS(ON)}$ with low gate charge, it can be used in a wide variety of applications.

General Features

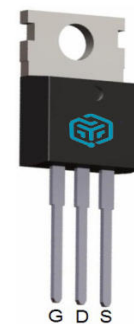
- $V_{DS} = 30V, I_D = 180A$
 $R_{DS(ON)} < 2.4m\Omega @ V_{GS}=10V$
 $R_{DS(ON)} < 5.0m\Omega @ V_{GS}=4.5V$
- High density cell design for ultra low R_{dson}
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high EAS
- Excellent package for good heat dissipation

Application

- Power switching application
- Hard switched and High frequency circuits
- Uninterruptible power supply



Schematic diagram



To-220 Top View

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
FNK03N024A	FNK03N024A	TO-220			

ABSOLUTE MAXIMUM RATINGS($T_A=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous@ Current-Pulsed (Note 1)	$I_D(25^{\circ}C)$	180	A
	I_{DM}	720	A
Maximum Power Dissipation	P_D	140	W
Single pulse avalanche energy(Note 5)	EAS	300	mJ

Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 150	$^{\circ}\text{C}$
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THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case (Note 2)	$R_{\theta JC}$	0.88	$^{\circ}\text{C/W}$
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ELECTRICAL CHARACTERISTICS ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

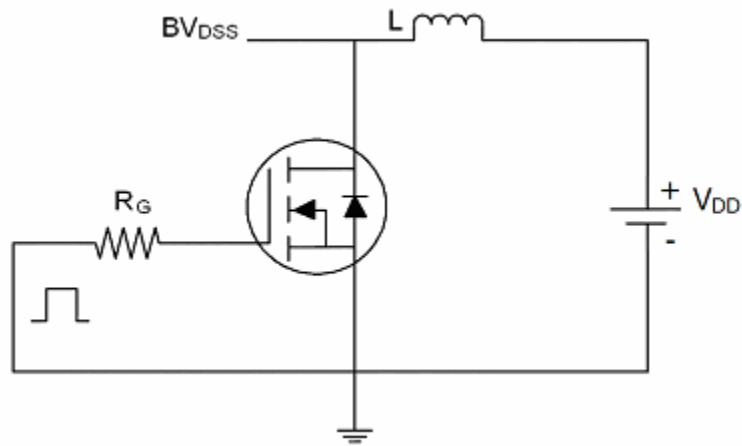
Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1.0	1.5	2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =10A			2.4	mΩ
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =6A			5.0	mΩ
DYNAMIC CHARACTERISTICS (Note4)						
Input Capacitance	C _{ISS}	V _{DS} =15V, V _{GS} =0V, F=1.0MHz		4945		PF
Output Capacitance	C _{OSS}			908		PF
Reverse Transfer Capacitance	C _{RSS}			493		PF
SWITCHING CHARACTERISTICS (Note 4)						
Delay Time	t _{d(on)}	V _{DS} =15V, V _{DS} =10V, R _{GEN} =6Ω R _L =1Ω, ID=50A		19		nS
Turn-on Rise Time	t _r			94		nS
Turn-Off Delay Time	t _{d(off)}			28		nS
Turn-Off Fall Time	t _f			30		nS
Total Gate Charge	Q _g	V _{DS} =15V, I _D =20A, V _{GS} =10V		35		nC
Gate-Source Charge	Q _{gs}			11		nC
Gate-Drain Charge	Q _{gd}			10		nC
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V, I _S =40A			1.2	V
Diode Forward Current (Note 2)	I _S				40	A
Reverse Recovery Time	trr	T _J = 25℃, I _F =90A di/dt = 100A/us (Note3)		47		ns
Reverse Recovery Charge	Q _{rr}			130		nc

NOTES:

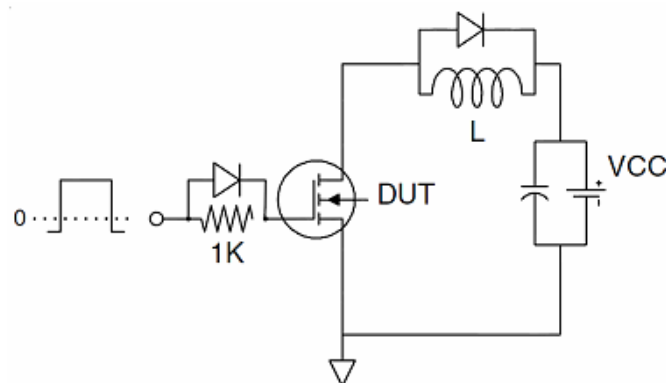
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on 1in² FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production testing
5. EAS condition $T_J=25^{\circ}\text{C}$, $V_{DD}=15V$, $V_G=10V$, $L=0.5mH$, $R_g=25\Omega$

Test circuit

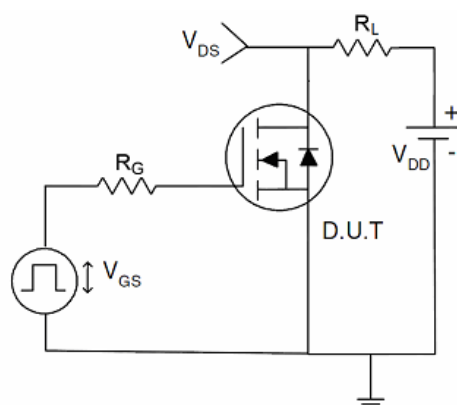
1) EAS test Circuits

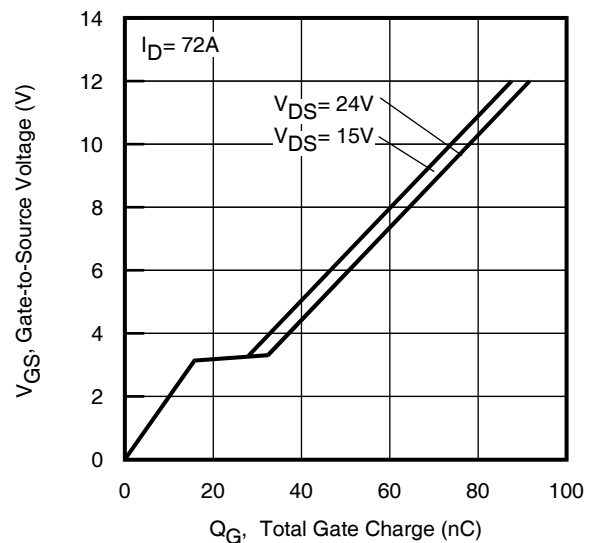
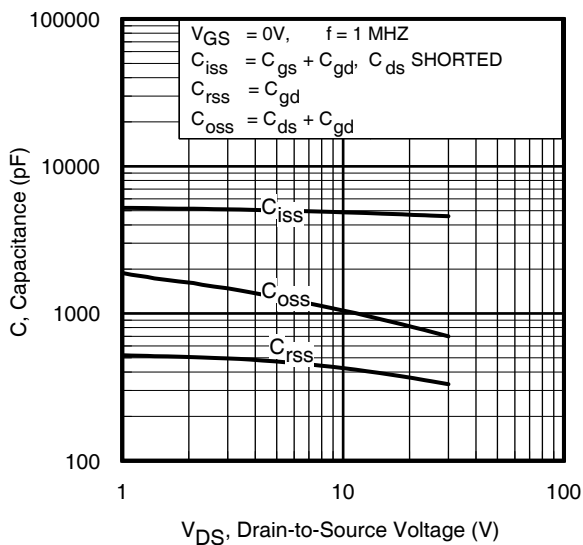
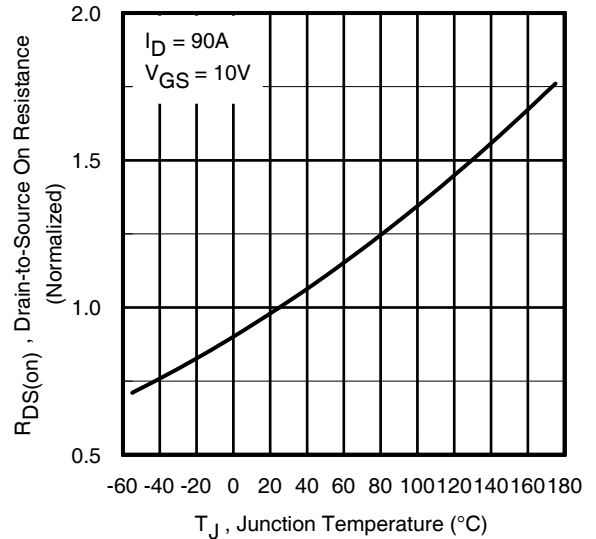
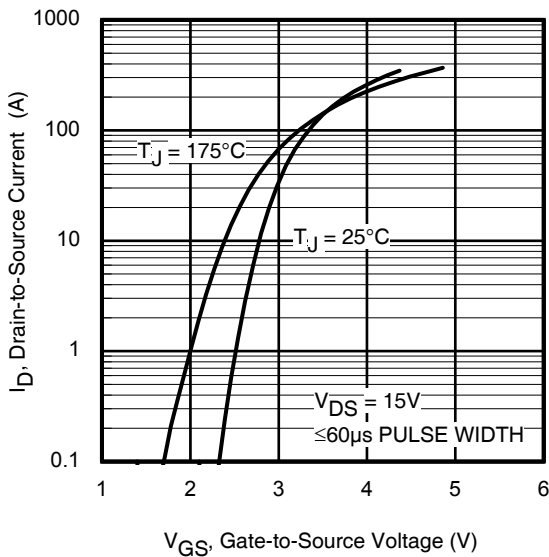
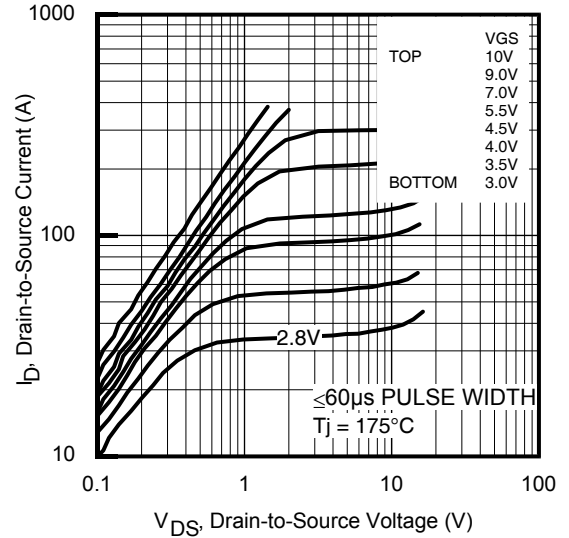
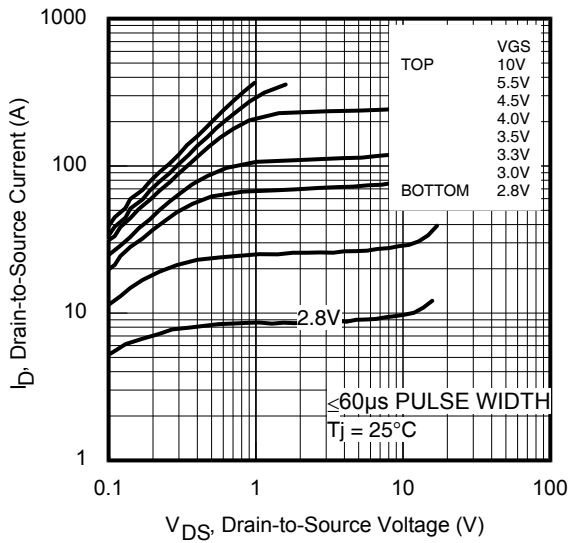


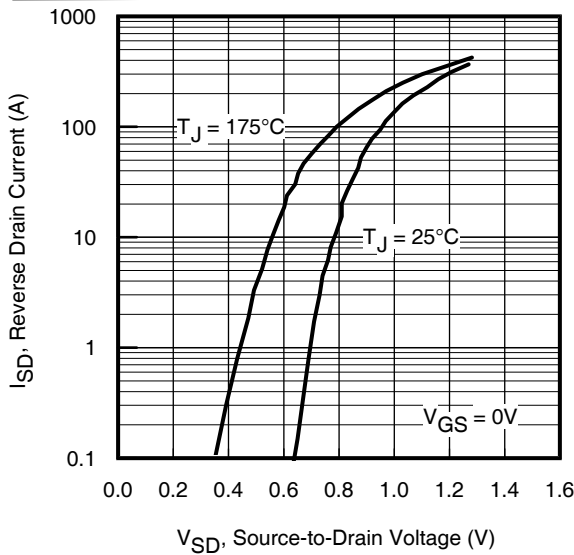
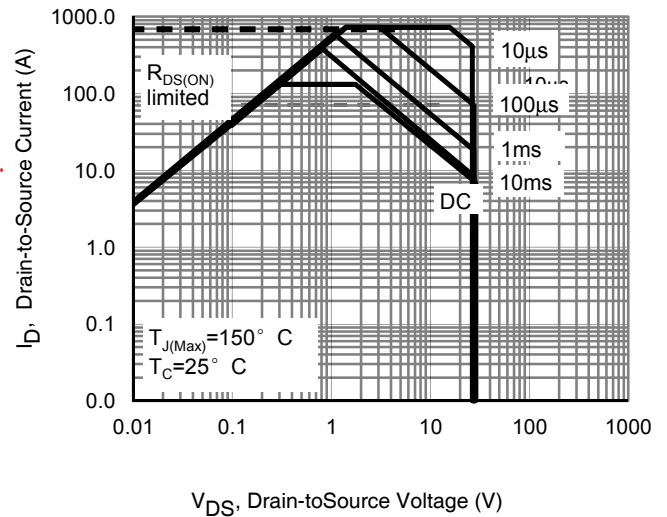
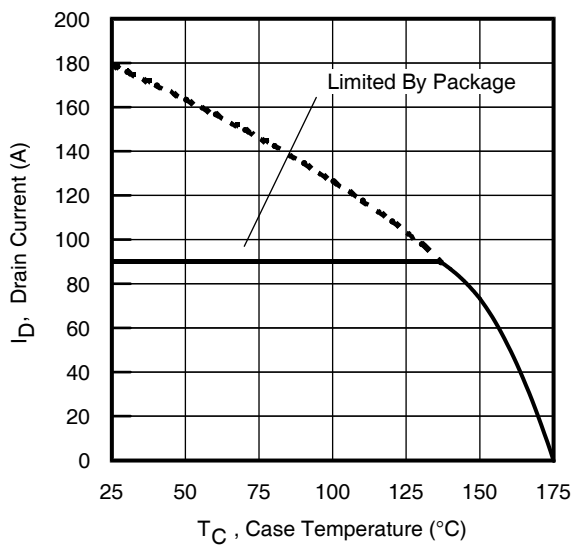
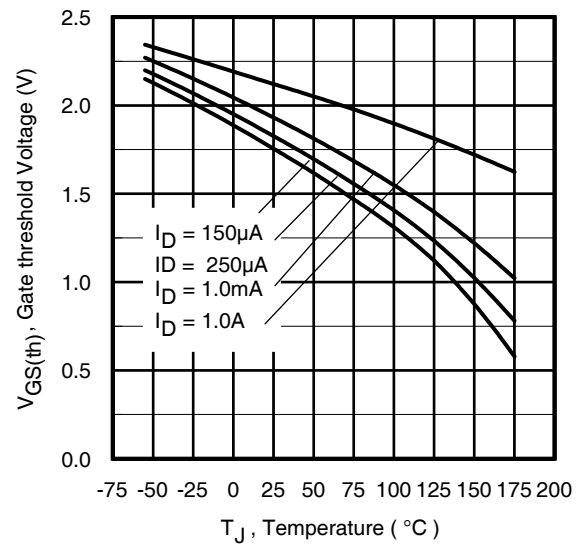
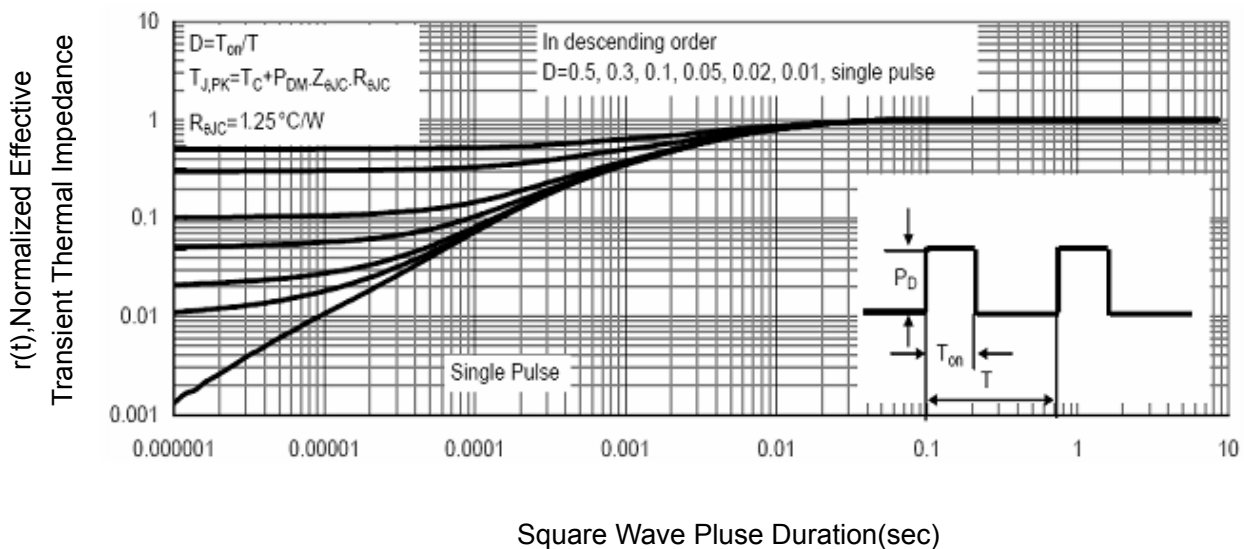
2) Gate charge test Circuit



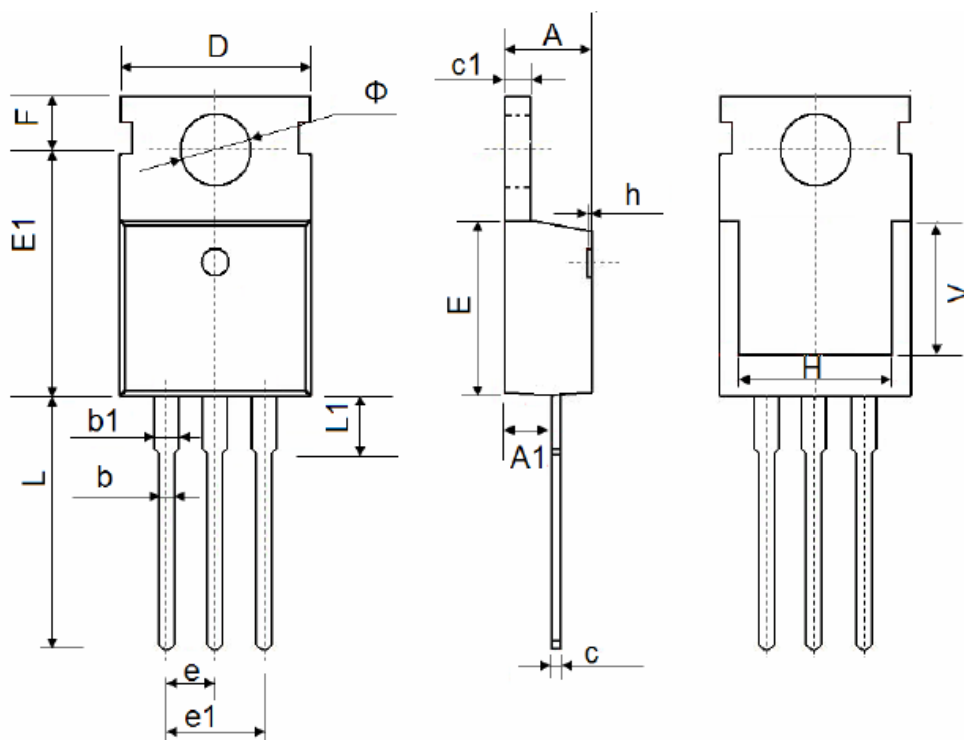
3) Switch Time Test Circuit



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Threshold Voltage vs. Temperature

Figure 11 Normalized Maximum Transient Thermal Impedance

TO-220 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.9500	9.750	0.352	0.384
E1	12.650	12.950	0.498	0.510
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
H	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	7.500 REF.		0.295 REF.	
Φ	3.400	3.800	0.134	0.150

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